

N-Channel 200 V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	200				
R _{DS(on)} (Ω)	V _{GS} = 10 V	0.85			
Q _g (Max.) (nC)	13				
Q _{gs} (nC)	3.0				
Q _{gd} (nC)	7.9				
Configuration	Single				

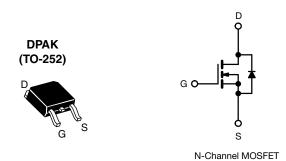
FEATURES

- TrenchFET[®] Power MOSFET
- 175 °C Junction Temperature
- **PWM Optimized**
- 100 % R_g Tested
- Compliant to RoHS Directive 2002/95/EC



APPLICATIONS

· Primary Side Switch



ABSOLUTE MAXIMUM RATINGS (To	c = 25 °C, un	ess otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	200	V	
Gate-Source Voltage			V_{GS}	± 20	7 °	
Continuous Drain Current	V _{GS} at 10 V	T _C = 25 °C		5.0		
Continuous Drain Current	V _{GS} at 10 V	T _C = 100 °C	I _D	4.0	Α	
Pulsed Drain Current ^a			I _{DM}	20		
Linear Derating Factor				0.33	W/°C	
Linear Derating Factor (PCB Mount) ^e				0.020	VV/ C	
Single Pulse Avalanche Energy b			E _{AS}	161	mJ	
Repetitive Avalanche Current a			I _{AR}	4.8	А	
Repetitive Avalanche Energy ^a			E _{AR}	4.2	mJ	
Maximum Power Dissipation	T _C =	T _C = 25 °C		42	W	
Maximum Power Dissipation (PCB mount) e	T _A = 25 °C		P_{D}	2.5		
Peak Diode Recovery dV/dt ^c			dV/dt	5.0	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +150	°C	
Soldering Recommendations (Peak temperature)	for 10 s			260	7 "	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD}=50~V$, starting $T_J=25~^{\circ}C$, L=14~mH, $R_g=25~\Omega$, $I_{AS}=4.8~A$ (see fig. 12). c. $I_{SD}\leq5.2~A$, $dI/dt\leq95~A/\mu s$, $V_{DD}\leq V_{DS}$, $T_J\leq150~^{\circ}C$.

- d. 1.6 mm from case.
- e. When mounted on 1" square PCB (FR-4 or G-10 material).

服务热线:400-655-8788

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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R _{thJA}	-	-	110	
Maximum Junction-to-Ambient (PCB mount) ^a	R _{thJA}	-	-	50	°C/W
Maximum Junction-to-Case (Drain)	R _{thJC}	-	-	3.0	

Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static					I.	I.	
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	= 0 V, I _D = 250 μA	200	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I _D = 1 mA	-	0.29	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	,	V _{GS} = ± 20 V	-	-	± 100	nA
Zava Cata Valtaga Dvais Coverent	I _{DSS}	V _{DS} =	V _{DS} = 200 V, V _{GS} = 0 V			25	
Zero Gate Voltage Drain Current		V _{DS} = 160 V	V _{DS} = 160 V, V _{GS} = 0 V, T _J = 125 °C		-	250	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 2.9 A ^b	-	0.85	-	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	V _{DS} = 50 V, I _D = 2.9 A ^b		-	-	S
Dynamic							
Input Capacitance	C_{iss}		$V_{GS} = 0 V$	-	185	-	
Output Capacitance	C _{oss}		$V_{DS} = 25 \text{ V},$	=	100	-	рF
Reverse Transfer Capacitance	C_{rss}	f = 1.	.0 MHz, see fig. 5	-	30	-	
Total Gate Charge	Qg			-	-	13.0	nC
Gate-Source Charge	Q _{gs}	$V_{GS} = 10 \text{ V}$	$I_D = 4.8 \text{ A}, V_{DS} = 160 \text{ V},$ see fig. 6 and 13 b	-		3.0	
Gate-Drain Charge	Q _{gd}		see lig. 6 and 13 °		-	7.9	
Turn-On Delay Time	t _{d(on)}				7.2	-	- ns
Rise Time	t _r	V_{DD} = 100 V, I_{D} = 4.8 A, R_{G} = 18 Ω , R_{D} = 20 Ω , see fig. 10 b		-	22	-	
Turn-Off Delay Time	t _{d(off)}			-	19	-	
Fall Time	t _f			-	13	-	
Internal Drain Inductance	L _D	6 mm (0.25") 1	Between lead, 6 mm (0.25") from		4.5	-	nH
Internal Source Inductance	L _S	package and center of die contact		-	7.5	-	ווח
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	4.8	Α
Pulsed Diode Forward Current ^a	I _{SM}			-	_	19	
Body Diode Voltage	V _{SD}	$T_J = 25 ^{\circ}\text{C}, I_S = 4.8 \text{A}, V_{GS} = 0 \text{V}^{ \text{b}}$		-	-	1.8	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 4.8 A, dI/dt = 100 A/µs b		-	150	300	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.91	1.8	μC
Forward Turn-On Time	t _{on}	Intrinsic tu	ırn-on time is negligible (turn	on is dor	ninated b	v Ls and	L _D)

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width \leq 300 μs ; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

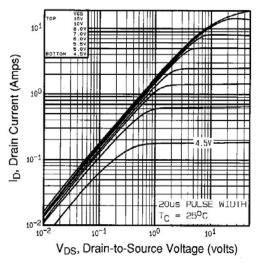


Fig. 1 - Typical Output Characteristics, $T_C = 25$ °C

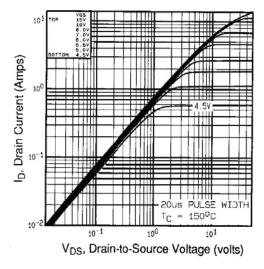


Fig. 2 - Typical Output Characteristics, $T_C = 150$ °C

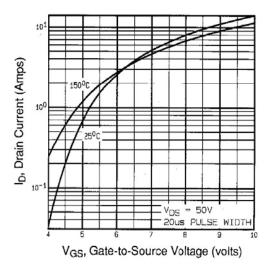


Fig. 3 - Typical Transfer Characteristics

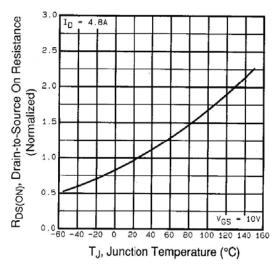


Fig. 4 - Normalized On-Resistance vs. Temperature



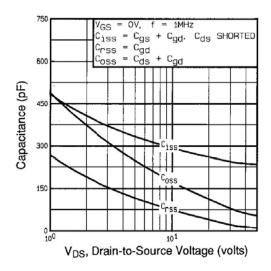


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

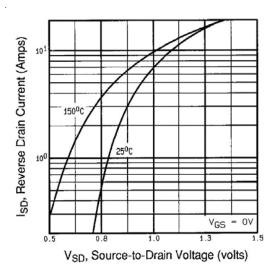


Fig. 7 - Typical Source-Drain Diode Forward Voltage

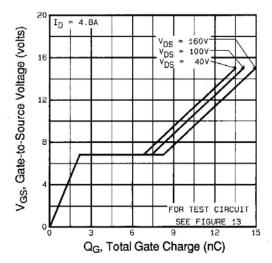


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

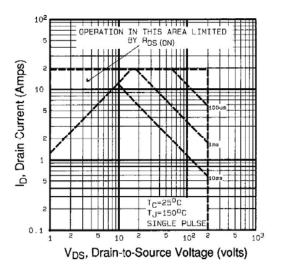


Fig. 8 - Maximum Safe Operating Area



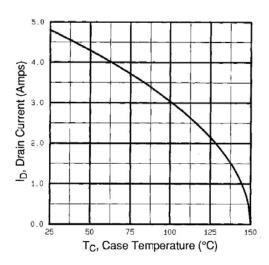


Fig. 9 - Maximum Drain Current vs. Case Temperature

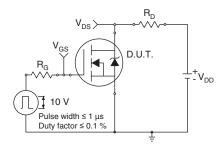


Fig. 10a - Switching Time Test Circuit

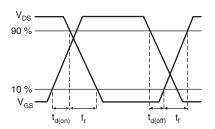


Fig. 10b - Switching Time Waveforms

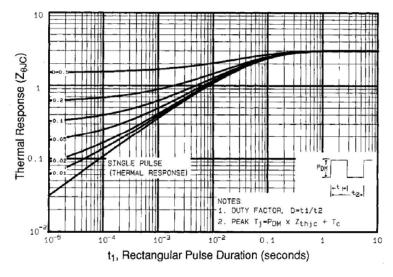


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



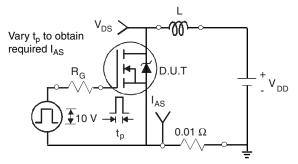


Fig. 12a - Unclamped Inductive Test Circuit

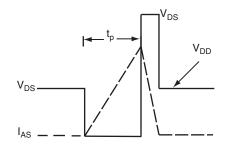


Fig. 12b - Unclamped Inductive Waveforms

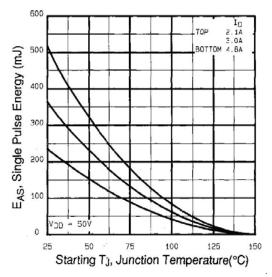


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

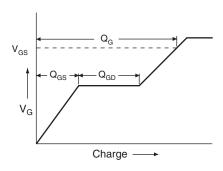


Fig. 13a - Basic Gate Charge Waveform

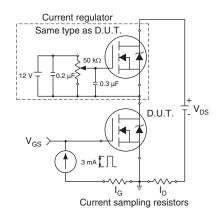
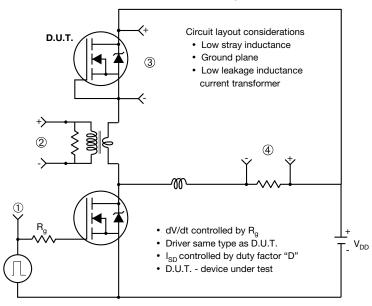


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



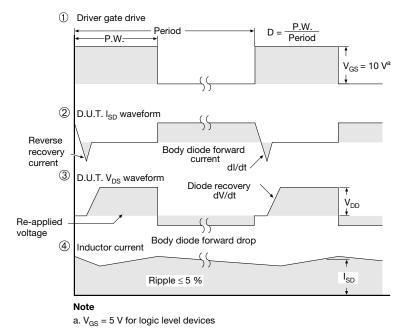
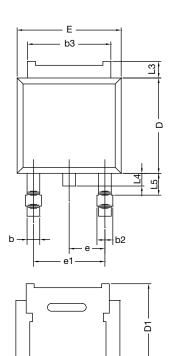
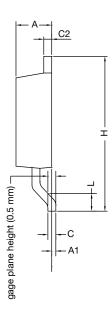


Fig. 14 - For N-Channel



TO-252AA Case Outline





	MILLIN	METERS	INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
Α	2.18	2.38	0.086	0.094	
A1	-	0.127	-	0.005	
b	0.64	0.88	0.025	0.035	
b2	0.76	1.14	0.030	0.045	
b3	4.95	5.46	0.195	0.215	
С	0.46	0.61	0.018	0.024	
C2	0.46	0.89	0.018	0.035	
D	5.97	6.22	0.235	0.245	
D1	4.10	-	0.161	-	
Е	6.35	6.73	0.250	0.265	
E1	4.32	-	0.170	-	
Н	9.40	10.41	0.370	0.410	
е	2.28 BSC		0.090 BSC		
e1	4.56 BSC		0.180 BSC		
L	1.40	1.78	0.055	0.070	
L3	0.89	1.27	0.035	0.050	
L4	-	1.02	-	0.040	
L5	1.01	1.52	0.040	0.060	
ECN: T16-0236-Rev. P, 16-May-16					

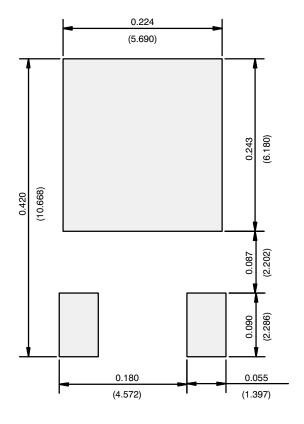
ECN: T16-0236-Rev. P, 16-May-16 DWG: 5347

Notes

• Dimension L3 is for reference only.



RECOMMENDED MINIMUM PADS FOR DPAK (TO-252)



Recommended Minimum Pads Dimensions in Inches/(mm)



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